

Search Notes**Application/Control No.**

10/017,554

Examiner

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Applicant(s)/Patent under Reexamination

PARK ET AL.

Art Unit

2664

SEARCHED

Class	Subclass	Date	Examiner
370	310.1 310.2	8/11/2005	BQN
370	332	8/12/2005	BQN
370	329	8/11/2005	BQN
370	328	8/11/2005	BQN
370	335	8/11/2005	BQN
370	342	8/15/2005	BQN
370	352	8/11/2005	BQN
455	550.1	8/11/2005	BQN
455	435.2	8/15/2005	BQN

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST (US-PGPUB, USPAT, USOCR, EPO, JPO, DERWENT, IBM_TDB)- See Search History Printout	8/11/2005	BQN
EAST, consulted Wellington Chin	8/15/2005	BQM

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner